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APPLICATION NO. FILING DATE		FILING DATE	FIRST NAMED INVENTOR	ATTORNEY DOCKET NO.	CONFIRMATION NO.		
10/762,568		01/23/2004	Gert-Jan Heerens	081468-0307814	3196		
909	7590	01/04/2005		EXAM	EXAMINER		
PILLSBU	RY WIN	ГHROP, LLP	NGUYEN	NGUYEN, HUNG			
P.O. BOX	10500						
MCLEAN,	VA 221	02	ART UNIT	PAPER NUMBER			
			2851				
			DATE MAILED: 01/04/2005				

Please find below and/or attached an Office communication concerning this application or proceeding.

	. <u>-</u>							
-		Appli	cation No.	Applicant(s)				
			62,568	HEERENS ET AL.				
	Office Action Summary	Exam	iner	Art Unit				
		Hung	Henry V Nguyen	2851				
Period fo	The MAILING DATE of this communic or Reply	cation appears of	n the cover sheet with the c	correspondence ad	idress			
A SH THE - Exte after - If the - If NO - Failu Any	ORTENED STATUTORY PERIOD FO MAILING DATE OF THIS COMMUNIOnsions of time may be available under the provisions of SIX (6) MONTHS from the mailing date of this commus period for reply specified above is less than thirty (30 period for reply is specified above, the maximum states to reply within the set or extended period for reply reply received by the Office later than three months af ed patent term adjustment. See 37 CFR 1.704(b).	CATION.  of 37 CFR 1.136(a). In a unication.  days, a reply within the utory period will apply a will, by statute, cause the	no event, however, may a reply be tine e statutory minimum of thirty (30) day and will expire SIX (6) MONTHS from a application to become ABANDONE	nely filed s will be considered timel the mailing date of this c (35 U.S.C. § 133).	ly. communication.			
Status								
1)	Responsive to communication(s) filed	d on <i>23 Januar</i> v	2004.					
·	•	b)⊠ This action						
·—	Since this application is in condition for allowance except for formal matters, prosecution as to the merits is							
,—	closed in accordance with the practice under <i>Ex parte Quayle</i> , 1935 C.D. 11, 453 O.G. 213.							
Disposit	ion of Claims							
5)□ 6)⊠ 7)□	Claim(s) 1-21 is/are pending in the application.  4a) Of the above claim(s) is/are withdrawn from consideration.  Claim(s) is/are allowed.  Claim(s) 1-21 is/are rejected.  Claim(s) is/are objected to.  Claim(s) are subject to restriction and/or election requirement.							
Applicat	ion Papers							
10)⊠	The specification is objected to by the The drawing(s) filed on 23 January 20 Applicant may not request that any object Replacement drawing sheet(s) including The oath or declaration is objected to	004 is/are: a)⊠ tion to the drawing the correction is re	g(s) be held in abeyance. Se equired if the drawing(s) is ob	e 37 CFR 1.85(a). jected to. See 37 C	FR 1.121(d).			
Priority (	ınder 35 U.S.C. § 119				·			
<ul> <li>12) Acknowledgment is made of a claim for foreign priority under 35 U.S.C. § 119(a)-(d) or (f).</li> <li>a) All b) Some * c) None of:</li> <li>1. Certified copies of the priority documents have been received.</li> <li>2. Certified copies of the priority documents have been received in Application No.</li> <li>3. Copies of the certified copies of the priority documents have been received in this National Stage application from the International Bureau (PCT Rule 17.2(a)).</li> <li>* See the attached detailed Office action for a list of the certified copies not received.</li> </ul>								
Attachmer	nt(s)		_					
	ce of References Cited (PTO-892)	FO 040;	4) Interview Summary Paper No(s)/Mail D					
3) Infor	ce of Draftsperson's Patent Drawing Review (Pr mation Disclosure Statement(s) (PTO-1449 or I er No(s)/Mail Date		5) Notice of Informal F		O-152)			

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#### **DETAILED ACTION**

#### Abstract

1. Applicant is reminded of the proper language and format for an abstract of the disclosure.

The abstract should be in narrative form and generally limited to a single paragraph on a separate sheet within the range of 50 to 150 words. It is important that the abstract not exceed 150 words in length since the space provided for the abstract on the computer tape used by the printer is limited. The form and legal phraseology often used in patent claims, such as "means" and "said," should be avoided. The abstract should describe the disclosure sufficiently to assist readers in deciding whether there is a need for consulting the full patent text for details.

The language should be clear and concise and should not repeat information given in the title. It should avoid using phrases which can be implied, such as, "The disclosure concerns," "The disclosure defined by this invention," "The disclosure describes," etc.

The abstract is objected to because the following term should be omitted" "comprises" lines 2 and 7. Correction is required.

### Claim Rejections - 35 USC § 102

2. The following is a quotation of the appropriate paragraphs of 35 U.S.C. 102 that form the basis for the rejections under this section made in this Office action:

A person shall be entitled to a patent unless -

- (b) the invention was patented or described in a printed publication in this or a foreign country or in public use or on sale in this country, more than one year prior to the date of application for patent in the United States.
- 3. Claims 1-21 are rejected under 35 U.S.C. 102(b) as being anticipated by Aoyama (U.S.Pat. 6,697,145).

With respect to claims 1, 6-8 and 13-15, and 20-21, Aoyama discloses a lithographic apparatus comprising all of the basic features of the instant claims such as: an illumination system (see col.6, lines 26-30) for providing a beam of radiation; a support structure constructed to support a patterning device (30) and the patterning device configured to impact the beam of radiation with a desired pattern in its cross-section; a substrate stage (25) for holding a substrate

(10); a projection system (28) for projecting the predetermined pattern formed on the patterning device onto the substrate and a conditioned chamber (2) for reducing pressure environment and reducing particle concentration environment (see col.6, lines 65-67) and an actuator (11, 12) configured to introduce at least one of the patterning device and the substrate into the condition chamber and an alignment system (17) configured to position the substrate in alignment with the projected patterned beam of radiation wherein the alignment system is disposed outside of the conditioned chamber (see figure 2)

As to claims 2, and 9-10, Aoyama teaches the actuator including an actuator arm having a carrier structure configured to move the substrate from the alignment system to the substrate stage. (see col.5, lines 25-42).

As to claims 3, and 17, the carrier structure is provided with a fixation device (11-14, 16) to fix the substrate to the carrier structure.

As to claims 4, 10-11, and 18-19, the alignment system (17) is provided with a docking system (figure 1) configured to dock the carrier structure.

### Claim Rejections - 35 USC § 103

- 4. The following is a quotation of 35 U.S.C. 103(a) which forms the basis for all obviousness rejections set forth in this Office action:
  - (a) A patent may not be obtained though the invention is not identically disclosed or described as set forth in section 102 of this title, if the differences between the subject matter sought to be patented and the prior art are such that the subject matter as a whole would have been obvious at the time the invention was made to a person having ordinary skill in the art to which said subject matter pertains. Patentability shall not be negatived by the manner in which the invention was made.
- 5. Claims 1-21 are rejected under 35 U.S.C. 103(a) as being unpatentable over Miyai et al (U.S.Pat. 5,825,470) in view of Nishi et al (U.S 2004/0223132).

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With respect to claims 1-21, Miyai et al discloses a lithographic apparatus comprising substantially all of the structures set forth in the instant claims including an illumination system (24-28) configured to provide a beam of radiation system; a support structure (32) for supporting a patterning device (30); a projection optical system (18) for projecting a predetermined pattern formed on the patterning device onto the substrate; a substrate stage (38, 40-44) for supporting the substrate (34); a conditioned chamber (12) for reducing the pressure and particle concentration environment; an actuator (70-72) configured to introduce at least one of the patterning device and the substrate into the conditioned chamber (12) (see figure 1). Miyai et al further teaches a robot hand control system (152) for controlling the movement of the transport arm of the actuator. Miyai et al does not expressly disclose an alignment system for positioning the substrate in alignment with projected beam of radiation. As discussed, Aoyama teaches an alignment system (17) provided outside of the conditioned chamber for positioning the substrate in alignment with the projected pattern beam of radiation so that no alignment is needed in the exposure system (see col.3, lines 24-29). In view of such teachings, it would have been obvious to one having ordinary skill in the art at the time the invention was made to combine the teachings of Miyai et al and Aoyama to obtain the invention as specified in claims 1-21 of the present invention. It would have been obvious to a skilled artisan to employ the alignment system as suggested by Aoyama into the lithographic system of Miyai for at least the purpose of "reducing the overall installation area of the exposure system, in which high performance air conditioned is required".

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## Prior Art Made of Record

6. The prior art made of record and not relied upon is considered pertinent to applicant's disclosure.

Nishi (US 2004/0223132 teaches a lithography system where an alignment system (37) is provided on a docking system to position the reticle (R) in alignment before it is transferred to the projected position.

7. Any inquiry concerning this communication or earlier communications from the examiner should be directed to Hung Henry V Nguyen whose telephone number is 571-272-2124. The examiner can normally be reached on Monday-Friday (First Friday off).

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Judy Nguyen can be reached on 571-272-2258. The fax phone number for the organization where this application or proceeding is assigned is 703-872-9306.

Information regarding the status of an application may be obtained from the Patent Application Information Retrieval (PAIR) system. Status information for published applications may be obtained from either Private PAIR or Public PAIR. Status information for unpublished applications is available through Private PAIR only. For more information about the PAIR system, see http://pair-direct.uspto.gov. Should you have questions on access to the Private PAIR system, contact the Electronic Business Center (EBC) at 866-217-9197 (toll-free).

> Hung Henry V Nguyen **Primary Examiner**

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hvn 12/28/04